

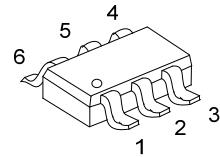
U74LVC2G04**CMOS IC****DUAL INVERTER****■ DESCRIPTION**

The **U74LVC2G04** is a dual inverter gate and it provides the Boolean function $Y = \bar{A}$ in positive logic.

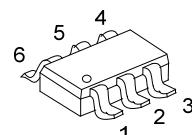
This device has power-down protective circuit to prevent the device from destruction when it is powered down.

■ FEATURES

- * Operate From 1.65V To 5.5V
- * Inputs Accept Voltages To 5.5V
- * High Noise Immunity
- * Low Power Dissipation
- * Max t_{PD} Of 3.2 ns At 5V



SOT-26

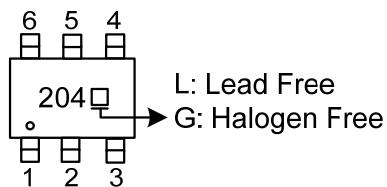


SOT-363

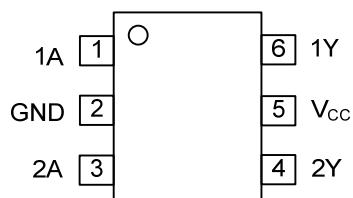
■ ORDERING INFORMATION

Ordering Number		Package	Packing
U74LVC2G04L-AL6-R	U74LVC2G04G-AG6-R	SOT-26	Tape Reel
U74LVC2G04L-AG6-R	U74LVC2G04G-AL6-R	SOT-363	Tape Reel

U74LVC2G04G-AG6-R 	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) AL6: SOT-363, AG6: SOT-26 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING

■ PIN CONFIGURATION

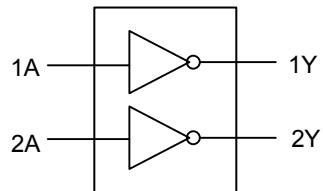


■ FUNCTION TABLE

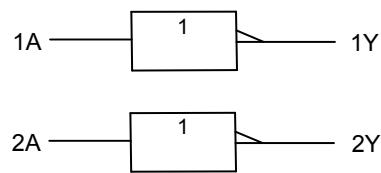
INPUT(nA)	OUTPUT(nY)
H	L
L	H

Note: H: HIGH voltage level; L: LOW voltage level.

■ LOGIC DIAGRAM (positive logic)



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V _{CC}	-0.5 ~ +6.5	V
Input Voltage	V _{IN}	-0.5 ~ +6.5	V
Output Voltage	V _{OUT}	-0.5 ~ V _{CC} +0.5	V
		-0.5 ~ +6.5	V
V _{CC} or GND Current	I _{CC}	±100	mA
Continuous Output Current (V _{OUT} =0 to V _{CC})	I _{OUT}	±50	mA
Input Clamp Current (V _{IN} <0)	I _{IK}	-50	mA
Output Clamp Current (V _{OUT} >V _{CC} or V _{OUT} <0)	I _{OK}	±50	mA
Power Dissipation (T _A =-40°C ~ +125°C)	P _D	300	mW
Operating Junction Temperature	T _J	-40 ~ +125	°C
Storage Temperature	T _{STG}	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	MIN	TYP	MAX	UNIT
Supply Voltage	V _{CC}	1.65		5.5	V
Input Voltage	V _{IN}	0		5.5	V
Output Voltage	V _{OUT}	0		V _{CC}	V
		0		5.5	V
Input Transition Rise or Fall Rate	V _{CC} =1.65V to 2.7V	0		20	ns/V
		0		10	ns/V

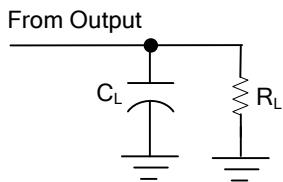
■ ELECTRICAL CHARACTERISTICS (T_A =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-level Input Voltage	V _{IH}	V _{CC} =1.65V ~ 1.95V	0.65×V _{CC}			V
		V _{CC} =2.3V ~ 2.7V	1.7			V
		V _{CC} =2.7V ~ 3.6V	2			V
		V _{CC} =4.5V ~ 5.5V	0.7×V _{CC}			V
Low-level Input Voltage	V _{IL}	V _{CC} =1.65V ~ 1.95V			0.35×V _{CC}	V
		V _{CC} =2.3V ~ 2.7V			0.7	V
		V _{CC} =2.7V ~ 3.6V			0.8	V
		V _{CC} =4.5V ~ 5.5V			0.3×V _{CC}	V
High-Level Output Voltage	V _{OH}	V _{CC} =1.65 ~ 5.5V, I _{OH} =-100μA	V _{CC} -0.1			V
		V _{CC} =1.65V, I _{OH} =-4mA	1.2			V
		V _{CC} =2.3V, I _{OH} =-8mA	1.9			V
		V _{CC} =2.7V, I _{OH} =-12mA	2.2			V
		V _{CC} =3.0V, I _{OH} =-24mA	2.3			V
		V _{CC} =4.5V, I _{OH} =-32mA	3.8			V
Low-Level Output Voltage	V _{OL}	V _{CC} =1.65 ~ 5.5V, I _{OL} =100μA			0.1	V
		V _{CC} =1.65V, I _{OL} =4mA			0.45	V
		V _{CC} =2.3V, I _{OL} =8mA			0.3	V
		V _{CC} =2.7V, I _{OL} =12mA			0.4	V
		V _{CC} =3.0V, I _{OL} =24mA			0.55	V
		V _{CC} =4.5V, I _{OL} =32mA			0.55	V
Input Leakage Current	I _{II(LEAK)}	V _{CC} =5.5V, V _{IN} =5.5V or GND		±0.1	±5	μA
Power OFF Leakage Current	I _{OFF}	V _{CC} =0V, V _{IN} or V _{OUT} =5.5V		±0.1	±10	μA
Quiescent Supply Current	I _Q	V _{CC} =5.5V, V _{IN} =V _{CC} or GND, I _{OUT} =0		0.1	10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI _{CC}	V _{CC} =2.3 ~ 5.5V, One input at V _{CC} -0.6V, Other inputs at V _{CC} or GND		5	500	μA

■ SWITCHING CHARACTERISTICS ($T_A = 25^\circ C$, unless otherwise specified)

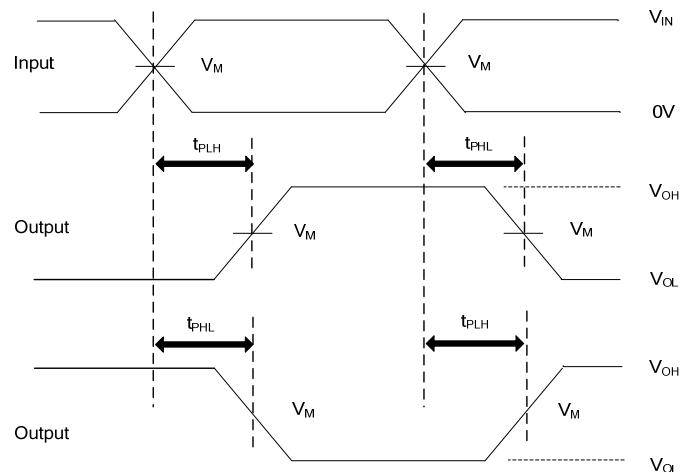
PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Propagation delay from input (A) to output(Y)	t_{PLH}	$C_L=30\text{pF}$	$V_{CC}=1.8\pm0.15V, R_L=1K\Omega$	1.0	3.5	8.0	ns
			$V_{CC}=2.5\pm0.2V, R_L=500\Omega$	1.0	2.2	4.4	ns
	t_{PHL}	$C_L=50\text{pF}$	$V_{CC}=2.7V, R_L=500\Omega$	1.0	2.7	5.2	ns
			$V_{CC}=3.3\pm0.3V, R_L=500\Omega$	0.5	2.7	4.1	ns
			$V_{CC}=5\pm0.5V, R_L=500\Omega$	1.0	1.9	3.2	ns

■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

V_{CC}	Inputs		V_M	C_L	R_L
	V_{IN}	t_R, t_F			
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	30pF	$1K\Omega$
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	30pF	500Ω
2.7V	2.7V	$\leq 2.5ns$	1.5V	50pF	500Ω
$3.3V \pm 0.3V$	2.7V	$\leq 2.5ns$	1.5V	50pF	500Ω
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	50pF	500Ω



PROPAGATION DELAY TIMES

Notes: 1. C_L includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10MHz$, $Z_0=50\Omega$.

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